

#### **Description**

The AP30P10P uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a

Battery protection or in other Switching application.

#### **General Features**

 $V_{DS} = -100V I_{D} = -30A$ 

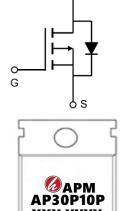
 $R_{DS(ON)}$  < -110m $\Omega$  @  $V_{GS}$ =-10V

## **Application**

**Battery protection** 

Load switch

Uninterruptible power supply





Package Marking and Ordering Information

ackage marking and Ordering information				
Product ID	Pack	Marking	Qty(PCS)	
AP30P10P	TO-220-3L	AP30P10P XXX YYYY	1000	

### Absolute Maximum Ratings (T<sub>C</sub>=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	-100	V
Vgs	Gate-Source Voltage	±20	V
I <sub>D</sub> @T <sub>C</sub> =25℃	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-30	А
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-16	А
Іом	Pulsed Drain Current <sup>2</sup>	-75	А
EAS	Single Pulse Avalanche Energy³	157.2	mJ
las	Avalanche Current	25	А
P <b></b> ₀@Tc=25℃	Total Power Dissipation <sup>4</sup>	96	W
Тѕтс	Storage Temperature Range	-55 to 150	$^{\circ}$
TJ	Operating Junction Temperature Range	-55 to 150	$^{\circ}$
R <sub>θ</sub> JA	Thermal Resistance Junction-Ambient <sup>1</sup>	62	°C/W
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	1.3	°C/W



## Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)

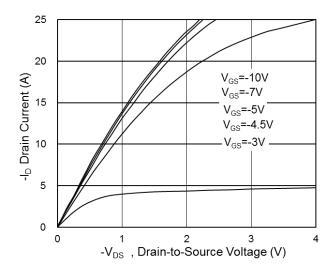
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA	-100			V
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-10V , I <sub>D</sub> =-10A		78	95	mΩ
KD3(ON)		V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-8A		86	110	11122
VGS(th)	Gate Threshold Voltage	$V_{GS}$ = $V_{DS}$ , $I_D$ =-250uA	-1.2	-1.7	-2.5	V
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =-100V , V <sub>GS</sub> =0V , T <sub>J</sub> =25℃			-50	uA
IGSS	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =-10V , I <sub>D</sub> =-10A		24		S
Qg	Total Gate Charge			44.5		
Qgs	Gate-Source Charge	V <sub>DS</sub> =-50V , V <sub>GS</sub> =-10V , I <sub>D</sub> =-20A		9.13		nC
Qgd	Gate-Drain Charge			5.93		
Td(on)	Turn-On Delay Time			12		
Tr	Rise Time	V <sub>DD</sub> =-50V , V <sub>GS</sub> =-10V ,		27.4		
Td(off)	Turn-Off Delay Time	R <sub>G</sub> =3.3Ω,I <sub>D</sub> =-10A		79		ns
Tf	Fall Time			53.6		
Ciss	Input Capacitance			3029		
Coss	Output Capacitance	V <sub>DS</sub> =-20V , V <sub>GS</sub> =0V , f=1MHz		129		pF
Crss	Reverse Transfer Capacitance			76		
IS	Continuous Source Current <sup>1,5</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-18	Α
VSD	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C			-1.2	V
trr	Reverse Recovery Time	IF=-8A , di/dt=-100A/μs ,		38.7		nS
Qrr	Reverse Recovery Charge	TJ=25℃		22.4		nC

#### Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2. The data tested by pulsed , pulse width  $\leqq 300 us$  , duty cycle  $\leqq 2\%$
- 3. The EAS data shows Max. rating . The test condition is VDD=-72V,VGS=-10V,L=0.1mH,IAS=-25A
- 4. The power dissipation is limited by 150  $^\circ\!\mathbb{C}$  junction temperature
- 5. The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation



## **Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

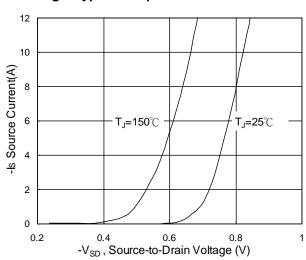


Fig.3 Typical S-D Diode Forward Voltage

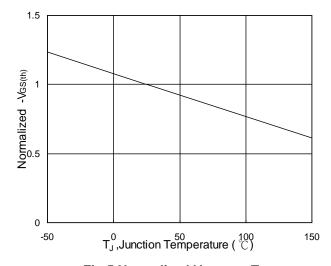


Fig.5 Normalized  $V_{\text{GS(th)}}$  vs  $T_{\text{J}}$ 

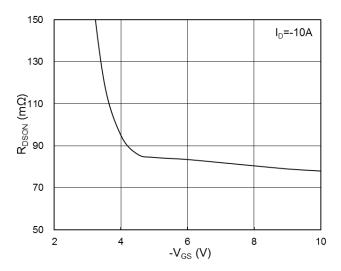


Fig.2 On-Resistance vs G-S Voltage

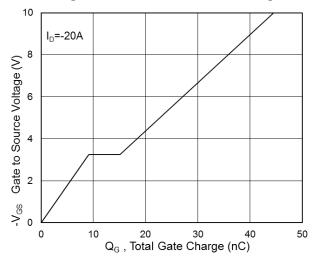


Fig.4 Gate-Charge Characteristics

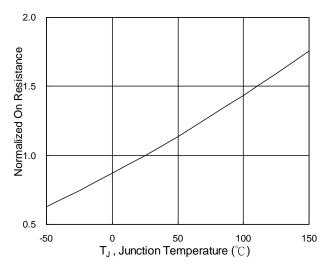
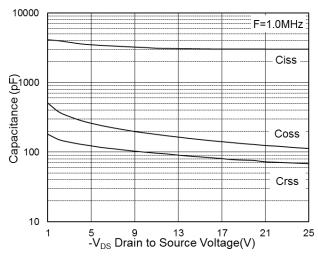


Fig.6 Normalized R<sub>DSON</sub> vs T<sub>J</sub>







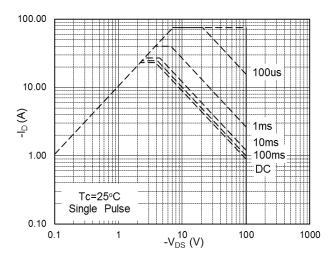


Fig.7 Capacitance

Fig.8 Safe Operating Area

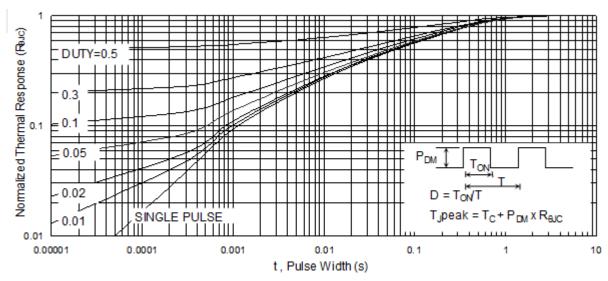


Fig.9 Normalized Maximum Transient Thermal Impedance

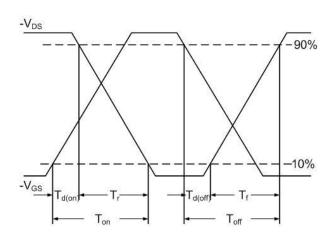


Fig.10 Switching Time Waveform

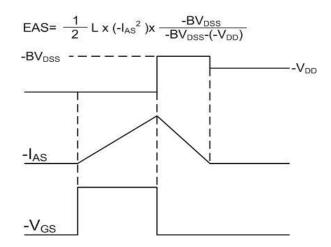
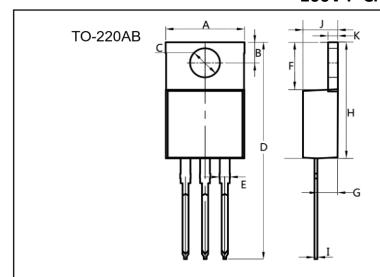
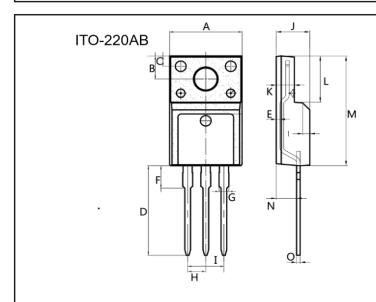


Fig.11 Unclamped Inductive Waveform

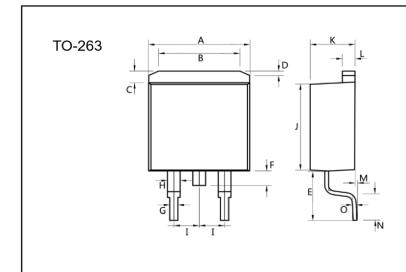




Dim.	Min.	Max.
Α	10.0	10.4
В	2.5	3.0
С	3.5	4.0
D	28.0	30.0
E	1.1	1.5
F	6.2	6.6
G	2.9	3.3
Н	15.0	16.0
I	0.35	0.45
J	4.3	4.7
K	1.2	1.4
All Dimensions in millimeter		



Dim.	Min.	Max.	
Α	9.9	10.3	
В	2.9	3.5	
С	1.15	1.45	
D	12.75	13.25	
E	0.55	0.75	
F	3.1	3.5	
G	1.25	1.45	
Н	Typ 2.54		
I	Typ 5.08		
J	4.55	4.75	
K	2.4	2. 7	
L	6.35	6.75	
М	15.0	16.0	
N	2.75	3.15	
0	0.45	0.60	
All Dimensions in millimeter			



Dim.	Min.	Max.	
Α	10.0	10. 5	
В	7.25	7.75	
С	1.3	1.5	
D	0.55	0.75	
E	5.0	6.0	
F	1.4	1.6	
G	0.75	0.95	
Н	1.15	1.35	
	Typ 2.54		
I	Тур	2.54	
J	Тур 8.4	2.54 8.6	
J K			
	8.4	8.6	
K	8.4 4.4	8.6 4.6	
K L	8.4 4.4 1.25	8.6 4.6 1.45	
K L M	8.4 4.4 1.25 0.02	8.6 4.6 1.45 0.1	
K L M N	8.4 4.4 1.25 0.02 2.4	8.6 4.6 1.45 0.1 2.8 0.45	



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Edition	Date	Change
RVE1.0	2020/3/25	Initial release

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